

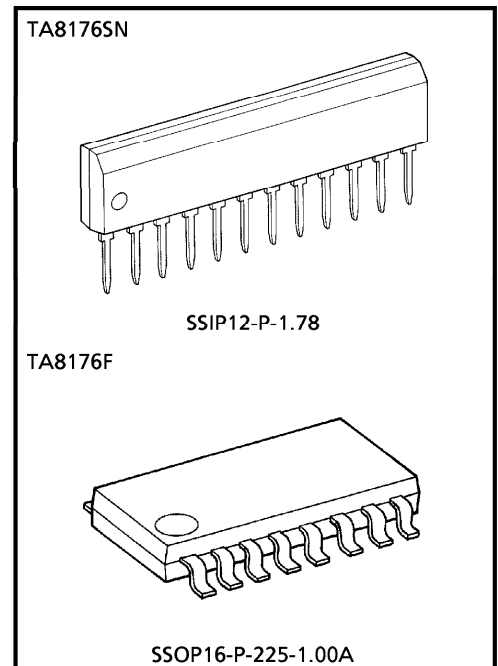
TA8176SN, TA8176F

FM FRONT END (FOR DIGITAL TUNING SYSTEM)

The TA8176SN, TA8176F are FM FRONT END ICs which are designed for radio cassette players and music centers. They are suitable for Digital Tuning System Applications.

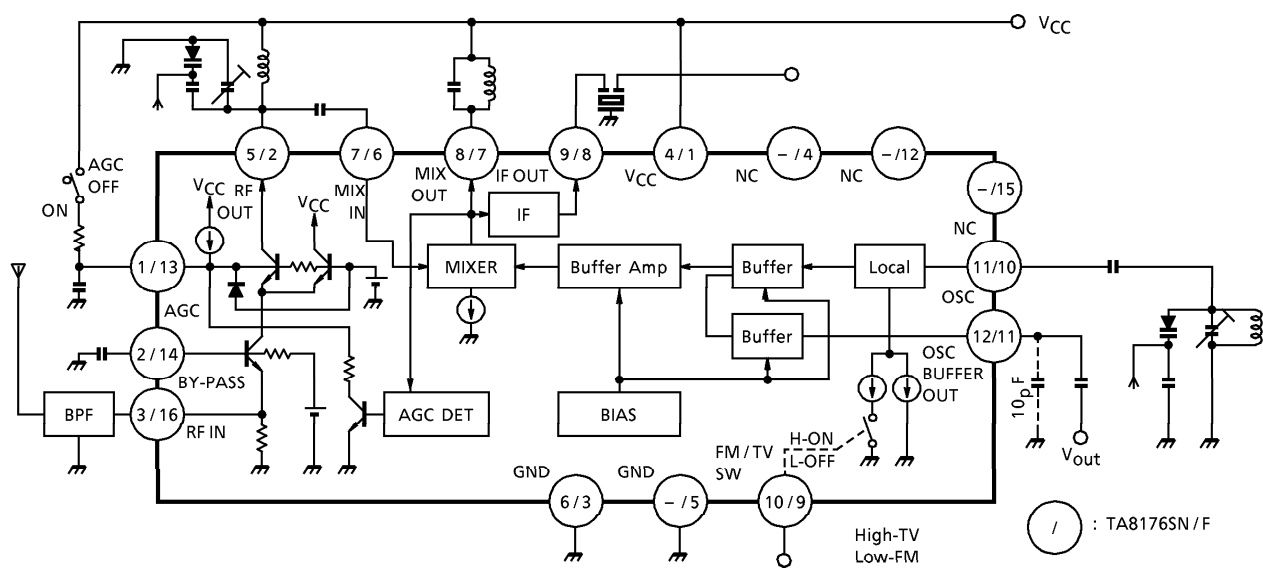
FEATURES

- Improved Inter-Modulation Characteristics by Double Balanced Type Mixer Circuit.
- Built-in Current Share Type AGC Circuit for the RF Amp.
- Applicable to double-tuning in radio frequency stage.
- Built-in Local Oscillator Buffer Output Circuit for Digital Tuning System Applications.
- Excellent overload characteristics for change oscillation frequency.
- It is available to TV band. (up to 220MHz)
- Built-in IF Amp.
: $R_O = 330\Omega$ (Typ.), $V_{out} = 80mV_{rms}$ (Typ.)
- Operating Supply Voltage Range
TA8176SN : $V_{CC(opr)} = 4\sim 14V$ ($T_a = 25^\circ C$)
TA8176F : $V_{CC(opr)} = 4\sim 8V$ ($T_a = 25^\circ C$)



Weight
SSIP12-P-1.78 : 0.65g (Typ.)
SSOP16-P-225-1.00A : 0.14g (Typ.)

BLOCK DIAGRAM



EXPLANATION OF TERMINALS (Terminal voltage shows the Typ. value at Ta = 25°C, VCC = 5V, AGC off,)
FM mode, and non-signal test circuit

PIN No. (SN / F)	SYMBOL	CONTENTS	INTERNAL CIRCUIT	DC VOLTAGE (V)
1 / 13	AGC	AGC ON / OFF Switch V1 / 13 = VCC → AGC OFF V1 / 13 = Open → AGC ON		4.7
2 / 14	BY-PASS (RF IN)	By-pass Terminal for RF Amp Circuit. It is necessary to connect External Capacitance. (RF Amp Input Terminal. Antenna Tuning Circuit is connected)		1.46
3 / 16	RF IN (BY-PASS)	RF Amp Input Terminal. (By-pass Terminal for RF Amp Circuit. It is necessary to connect External Capacitance)		0.76
4 / 1	VCC	Power Supply	—	5.0
5 / 2	RF OUT	RF Amp Output Terminal. RF Tuning Circuit is connected	Compare with Pin① / ⑬, ② / ⑭, ③ / ⑯	5.0

2001-06-25

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC		SYMBOL	RATING	UNIT
Supply Voltage	TA8176SN	V _{CC}	15	V
	TA8176F		9	
Power Dissipation	TA8176SN	P _D (Note)	750	mW
	TA8176F		350	
Operating Temperature		T _{opr}	- 25~75	°C
Storage Temperature		T _{stg}	- 55~150	°C

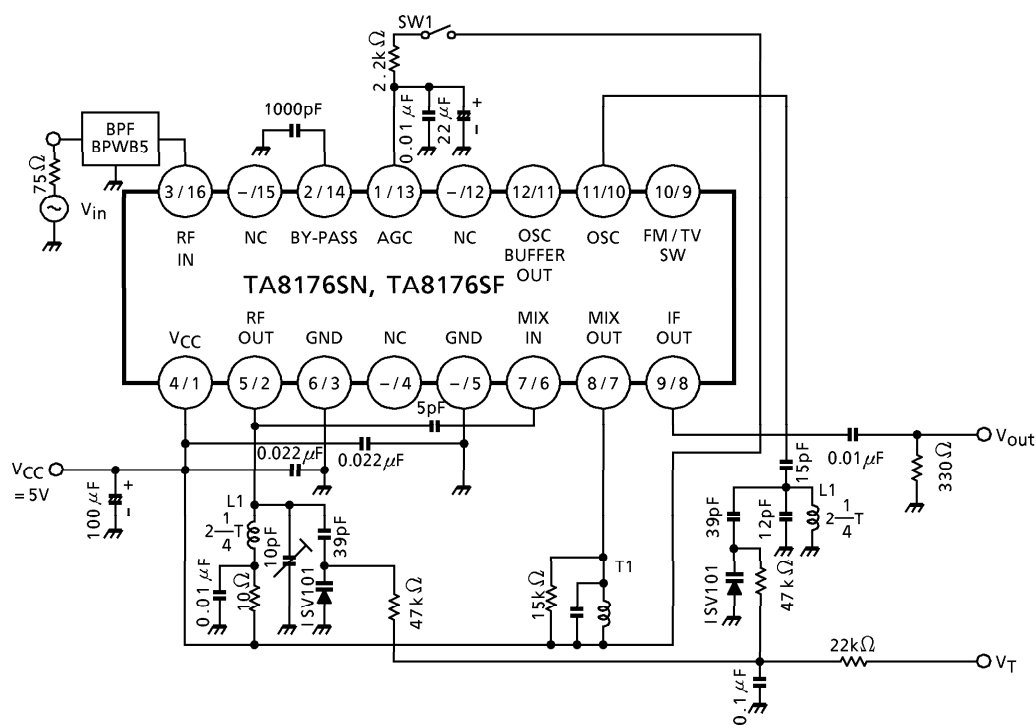
(Note) Derated above Ta = 25°C in the proportion of 6mW/°C for TA8176SN and of 2.8mW/°C for TA8176F.

ELECTRICAL CHARACTERISTICS (Unless otherwise specified, V_{CC} = 5V, Ta = 25°C, f = 98MHz, fm = 1kHz, $\Delta f = \pm 22.5\text{kHz}$, SW1 = ON, SW2 = OFF)

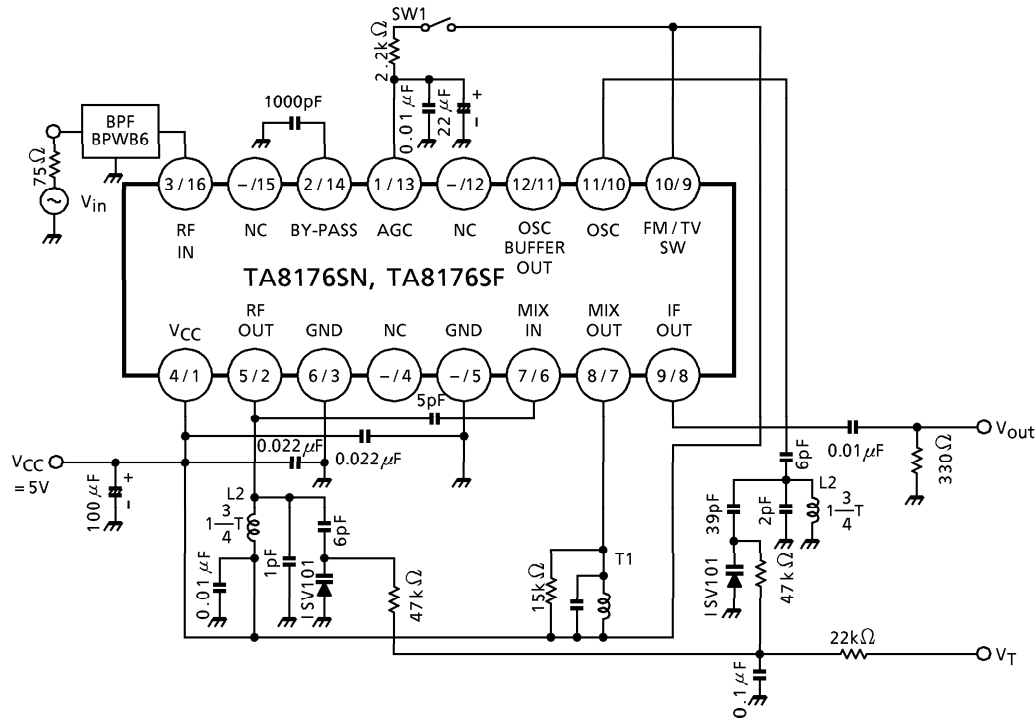
CHARACTERISTIC	SYMBOL	TEST CIR-CUIT	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Supply Current	I _{CC1}	1	V _{in} = 0	—	16.5	22	mA
	I _{CC2}	2	V _{in} = 0	—	17.0	22.5	
Conversion Gain	G _{C1}	1	f _{in} = 98MHz V _{in} = 50dB μ V EMF G _{C1} = 20log ₁₀ $\frac{V_{out}}{V_{in}}$	37	41	—	dB
	G _{C2}	2	f _{in} = 180MHz V _{in} = 55dB μ V EMF G _{C2} = 20log ₁₀ $\frac{V_{out}}{V_{in}}$	36	40	—	
Local OSC Voltage	V _{osc1}	3	f _{OSC} = 108.7MHz	—	275	—	mV _{rms}
	V _{osc2}	3	f _{OSC} = 190.7MHz SW2 = ON	—	150	—	
Local OSC Buffer output Voltage	V _O (osc1)	3	f _{OSC} = 108.7MHz	45	80	—	mV _{rms}
	V _O (osc2)	3	f _{OSC} = 190.7MHz SW2 = ON	—	80	—	
IF Amp. Output Voltage	V _{out1}	1	f _{in} = 98MHz V _{in} = 80dB μ V EMF	—	130	—	mV _{rms}
	V _{out2}	2	f _{in} = 98MHz V _{in} = 80dB μ V EMF	—	130	—	
Local OSC Stop Voltage	V _{stop1}	3	f _{OSC} = 108.7MHz	—	2.5	2.8	V
	V _{stop2}	3	f _{OSC} = 190.7MHz SW2 = ON	—	2.7	3.0	

CHARACTERISTIC		SYMBOL	TEST CIR- CUIT	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Pin③ / ⑩ Impedance	Parallel Input Resistance	$r_{ip3/16}$	4	$f = 98\text{MHz}$	—	42	—	Ω
	Parallel Input Capacitance	$c_{ip3/16}$	4		—	— 12	—	pF
Pin⑤ / ② Impedance	Parallel Output Resistance	$r_{op5/2}$	4		—	10	—	k Ω
	Parallel Output Capacitance	$c_{op5/2}$	4		—	7.3	—	pF
Pin⑦ / ⑥ Impedance	Parallel Input Resistance	$r_{ip7/6}$	4		—	2.7	—	k Ω
	Parallel Input Capacitance	$c_{ip7/6}$	4		—	6.7	—	pF
Pin⑧ / ⑦ Impedance	Parallel Output Resistance	$r_{op8/7}$	4	$f = 10.7\text{MHz}$	—	39	—	k Ω
	Parallel Output Capacitance	$c_{op8/7}$	4		—	6.7	—	pF
Pin⑫ / ⑪ Impedance	Parallel Output Resistance	$r_{op12/11}$	4	$f = 108\text{MHz}$	—	95	—	Ω
	Parallel Output Capacitance	$c_{op12/11}$	4		—	1.4	—	pF

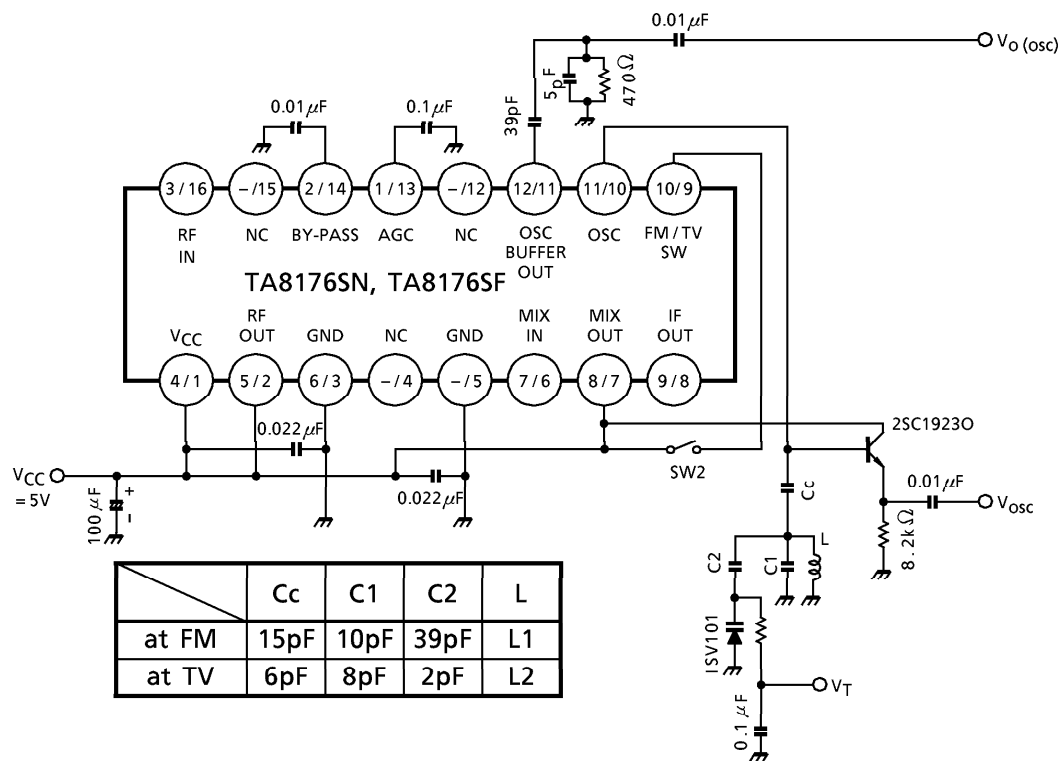
TEST CIRCUIT 1



TEST CIRCUIT 2



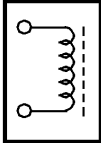
TEST CIRCUIT 3



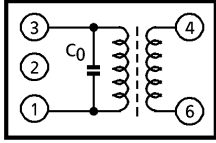
COIL DATA

COIL No.	STAGE	TEST FREQ	L (μ H)	C ₀ (pF)	Q ₀	TURNS				WIRE (mm)	REMARKS
						①-②	②-③	①-③	④-⑥		
L1	FM RF / OSC	100MHz	0.06		100		2 $\frac{1}{4}$			ϕ 0.5 UEW	Within Core
L2	TV RF / OSC	100MHz	0.045		100		1 $\frac{3}{4}$			ϕ 0.5 UEW	Within Core
T1	FM IFT	10.7MHz		75	100			13	2	ϕ 0.16 UEW	SUMIDA 2153-414-041A

L1, L2

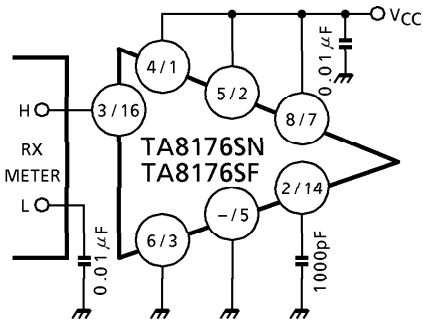


T1

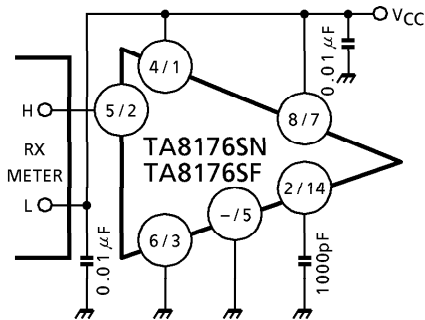


TEST CIRCUIT 4

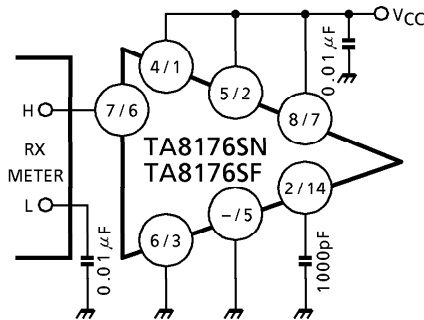
Pin③ / ⑩ input impedance



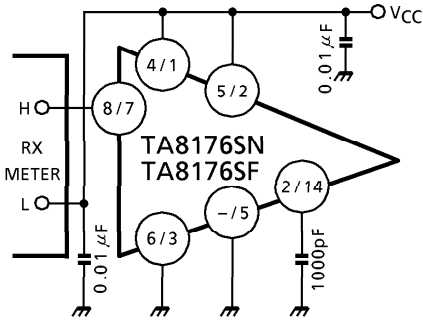
Pin⑤ / ② output impedance



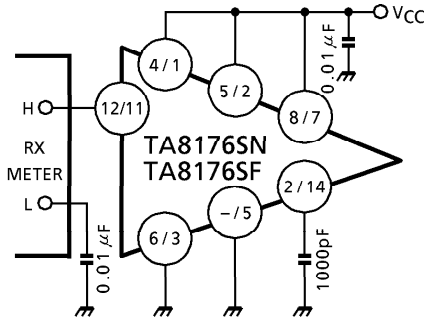
Pin⑦ / ⑥ input impedance

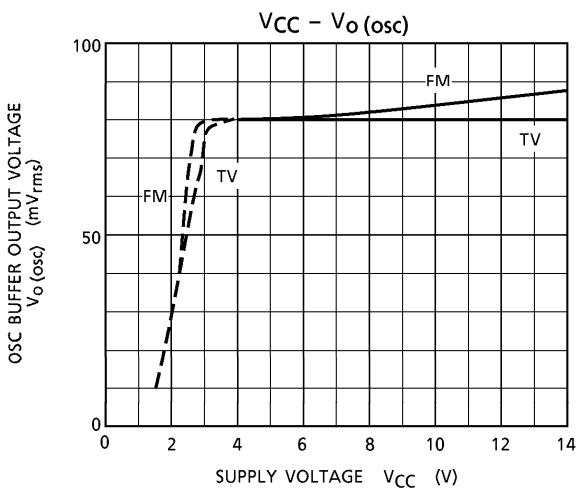
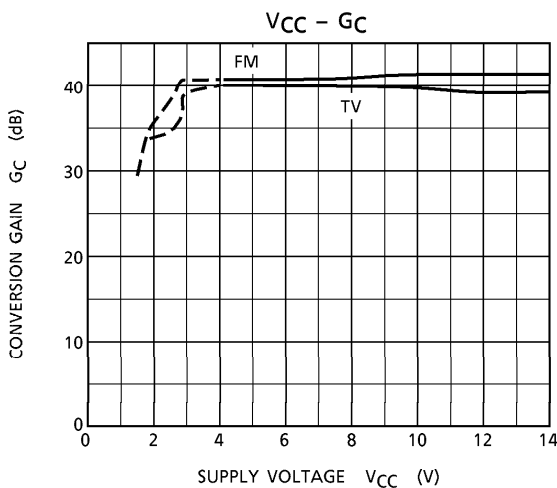
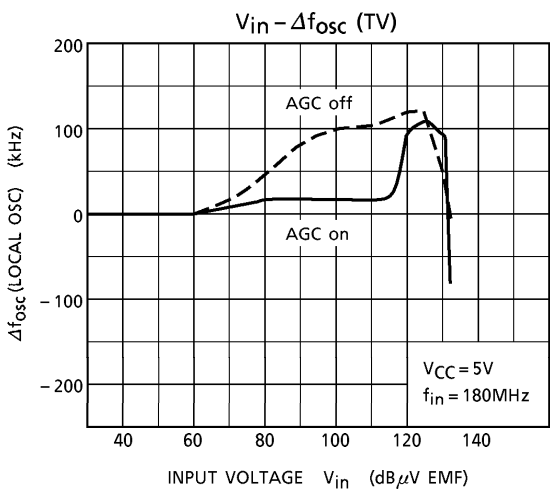
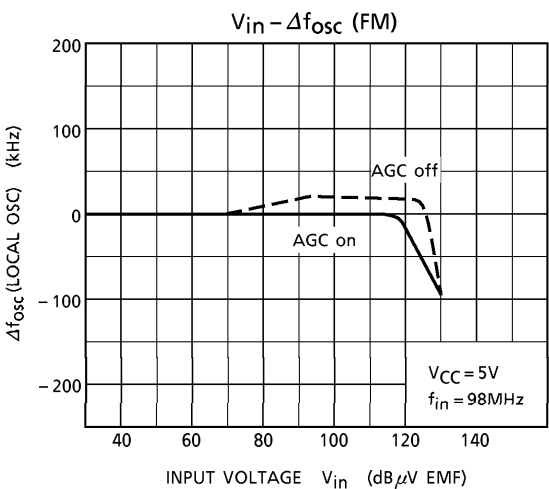
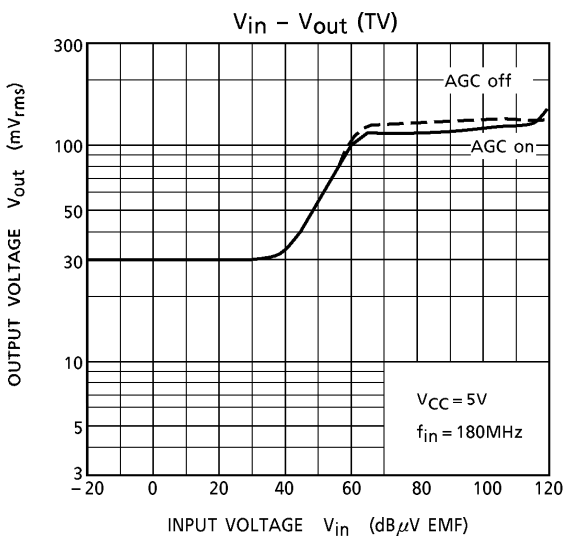
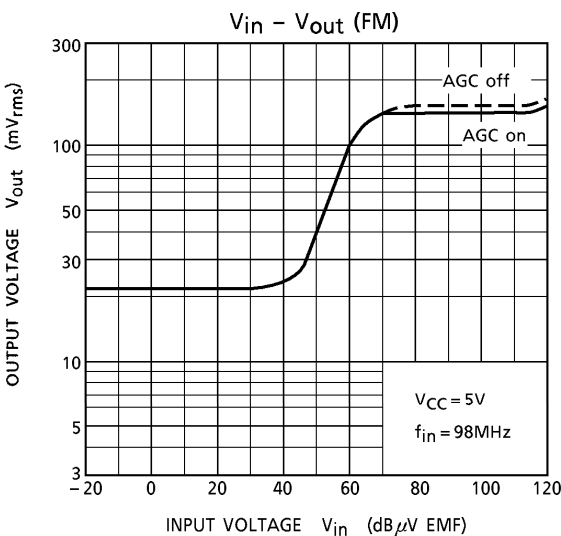


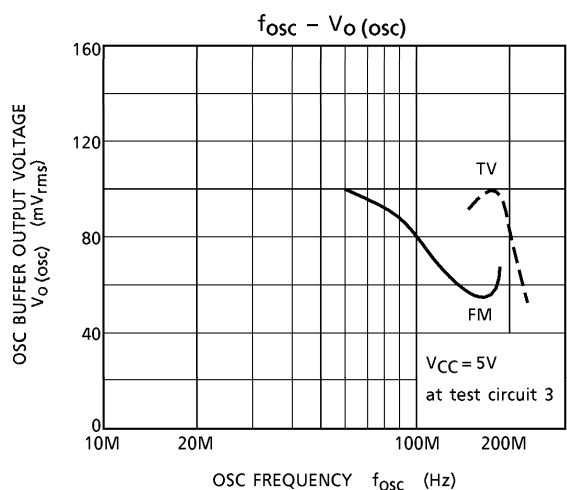
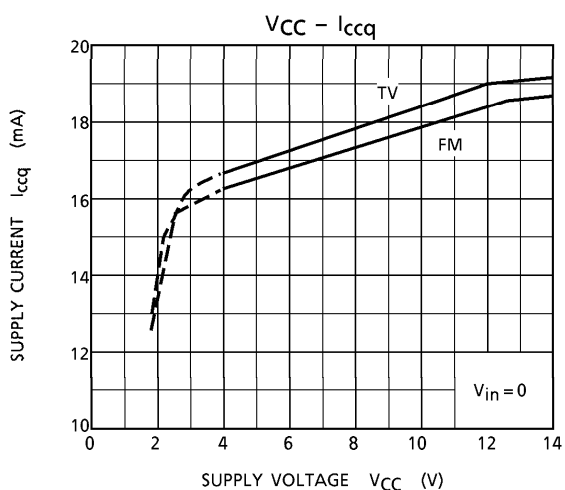
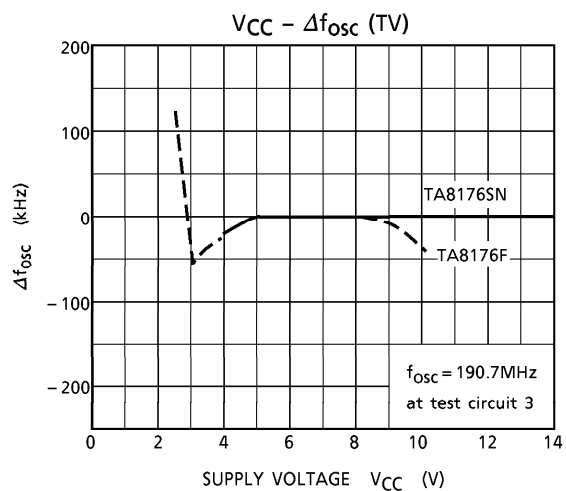
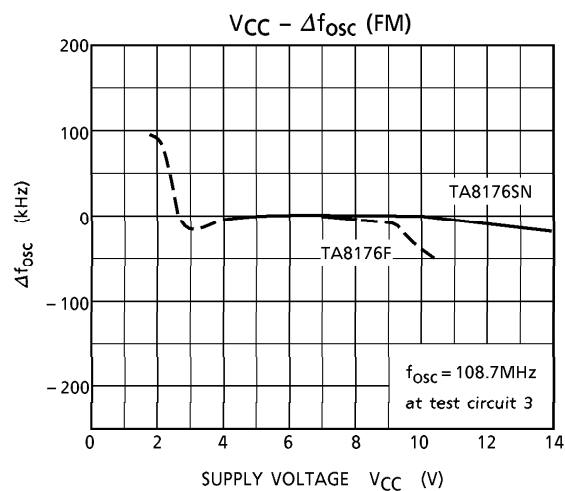
Pin⑧ / ⑦ output impedance



Pin⑫ / ⑪ output impedance

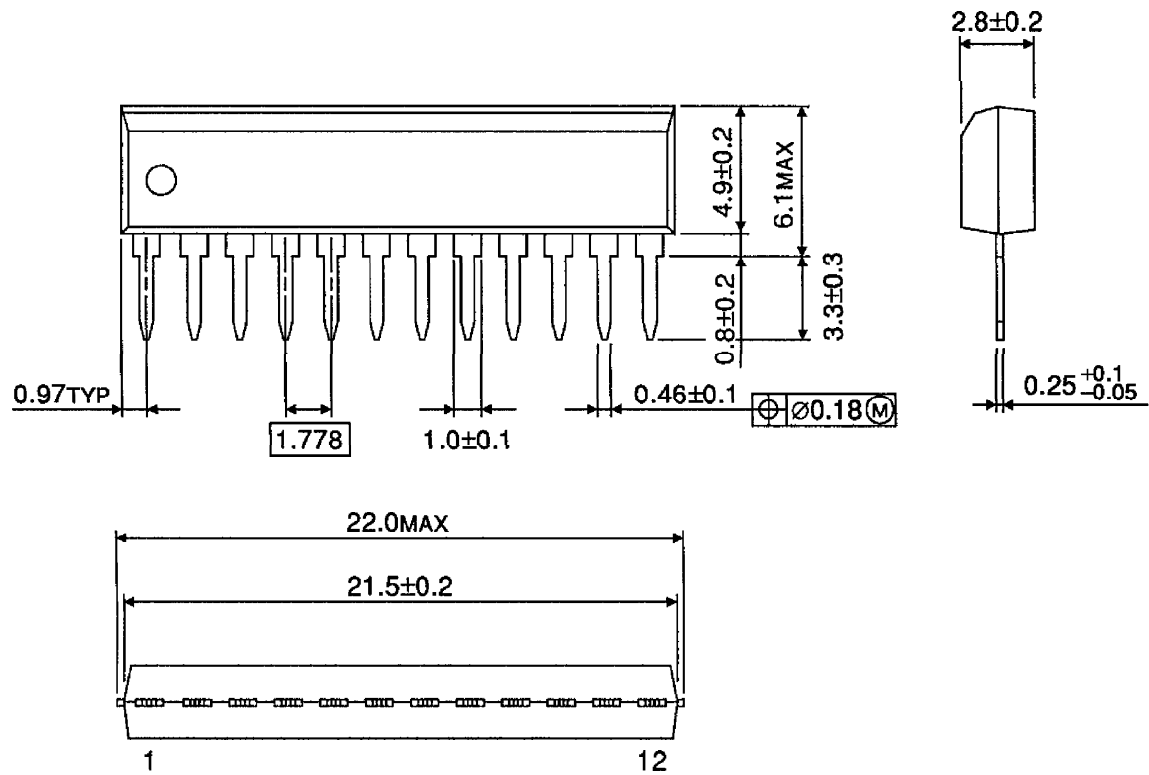






PACKAGE DIMENSIONS
SSIP12-P-1.78

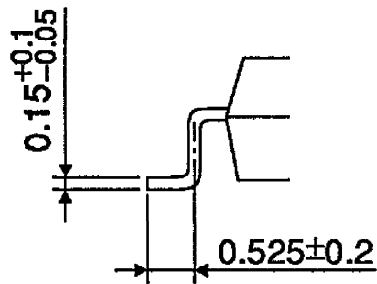
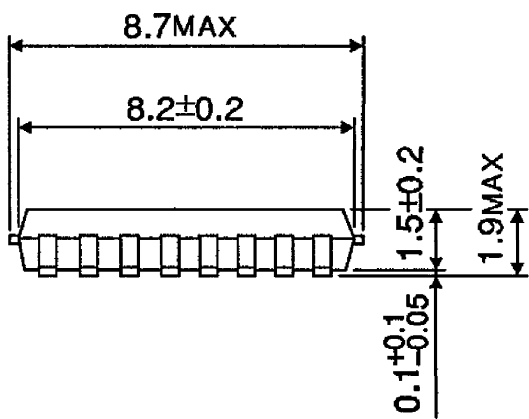
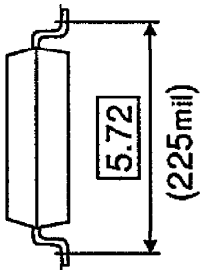
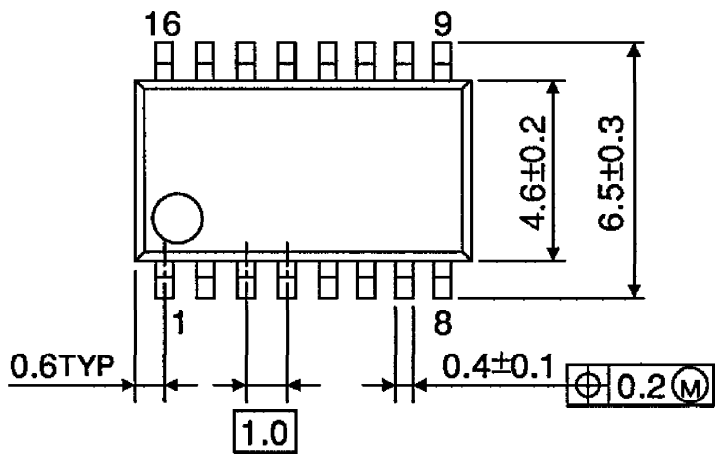
Unit : mm



Weight : 0.65g (Typ.)

PACKAGE DIMENSIONS
SSOP16-P-225-1.00A

Unit : mm



Weight : 0.14g (Typ.)

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000707EBA

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